

Notice of References Cited	Application/Control No. 10/521,674		Applicant(s)/Patent Under Reexamination WEYL ET AL.	
	Examiner BACH T. DINH		Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2001/0025522	10-2001	Kojima, Takashi	73/31.05
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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